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10/718,630 Examiner

John E. Chapman

Applicant(s)/Patent under Reexamination

HIGUCHI, HIROFUMI

Art Unit

2856

SEARCHED					
Class	Subclass	Date	Examiner		
73	504.12				
	504.14				
310	309				
331	154	8/4/2005	X		
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INTERFERENCE SEARCHED						
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